	Se	arch	Notes	
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/550,135	WEIS ET AL.	
Examiner	Art Unit	
Thomas J. Brahan	3654	

	SEARCHED		
Class	Subclass	Date	Examiner

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Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST attached	4/27/2007	TJB	
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